

## General Description

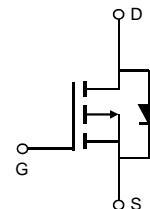
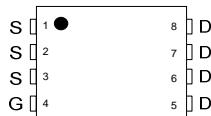
The AON6411 combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

## Features

$V_{DS}$	-20
$I_D$ (at $V_{GS} = -10V$ )	-85A
$R_{DS(ON)}$ (at $V_{GS} = -10V$ )	< 2.1mΩ
$R_{DS(ON)}$ (at $V_{GS} = -4.5V$ )	< 2.5mΩ
$R_{DS(ON)}$ (at $V_{GS} = -2.5V$ )	< 3.6mΩ



Top View



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	-20	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	V
Continuous Drain Current <sup>G</sup>	$I_D$	-85	A
$T_C=100^\circ C$	$I_D$	-67	
Pulsed Drain Current <sup>C</sup>	$I_{DM}$	-340	
Continuous Drain Current	$I_{DSM}$	-47	A
$T_A=70^\circ C$	$I_{DSM}$	-38	
Avalanche Current <sup>C</sup>	$I_{AS}$	70	A
Avalanche energy $L=0.1mH$ <sup>C</sup>	$E_{AS}$	245	mJ
Power Dissipation <sup>B</sup>	$P_D$	156	W
$T_C=100^\circ C$	$P_D$	62.5	
Power Dissipation <sup>A</sup>	$P_{DSM}$	7.3	W
$T_A=70^\circ C$	$P_{DSM}$	4.7	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	°C

### Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	14	17	°C/W
Maximum Junction-to-Ambient <sup>A,D</sup>		40	55	°C/W
Maximum Junction-to-Case	$R_{\theta JC}$	0.6	0.8	°C/W

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V	-20			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-20V, V <sub>GS</sub> =0V T <sub>J</sub> =55°C			-1 -5	μA
I <sub>GSS</sub>	Gate-Body leakage current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±12V			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA	-0.5	-0.85	-1.3	V
I <sub>D(ON)</sub>	On state drain current	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V	-340			A
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A T <sub>J</sub> =125°C		1.7	2.1	mΩ
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-20A		2.45	3	mΩ
		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-20A		2	2.5	mΩ
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-20A		2.8	3.6	mΩ
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =-1A, V <sub>GS</sub> =0V		-0.57	-1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Current <sup>G</sup>				-85	A
<b>DYNAMIC PARAMETERS</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =-10V, f=1MHz		10290		pF
C <sub>oss</sub>	Output Capacitance			1910		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			1395		pF
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz		2.1	4.2	Ω
<b>SWITCHING PARAMETERS</b>						
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-10V, I <sub>D</sub> =-20A		235	330	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge			100	140	nC
Q <sub>gs</sub>	Gate Source Charge			21		nC
Q <sub>gd</sub>	Gate Drain Charge			36		nC
t <sub>D(on)</sub>	Turn-On Delay Time	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-10V, R <sub>L</sub> =0.5Ω, R <sub>GEN</sub> =3Ω		9		ns
t <sub>r</sub>	Turn-On Rise Time			18		ns
t <sub>D(off)</sub>	Turn-Off Delay Time			282		ns
t <sub>f</sub>	Turn-Off Fall Time			90		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =-20A, dI/dt=500A/μs		48		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =-20A, dI/dt=500A/μs		178		nC

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25° C. Maximum UIS current limited by test equipment.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

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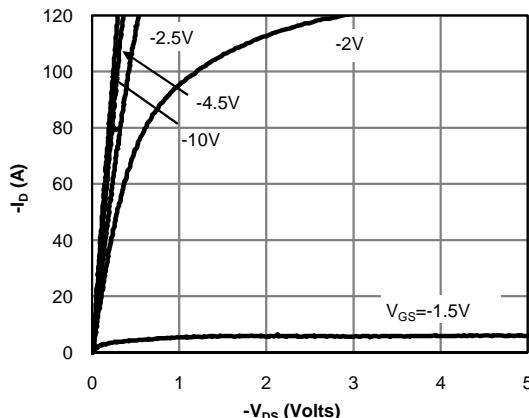
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


Fig 1: On-Region Characteristics (Note E)

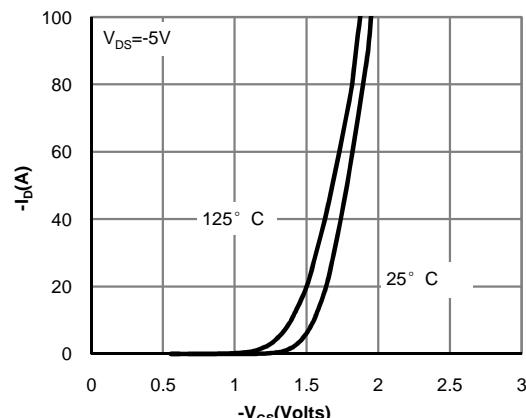


Figure 2: Transfer Characteristics (Note E)

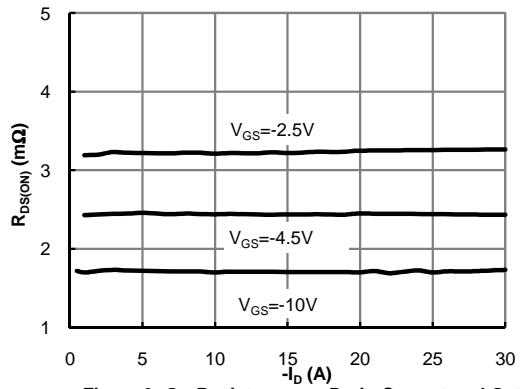


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

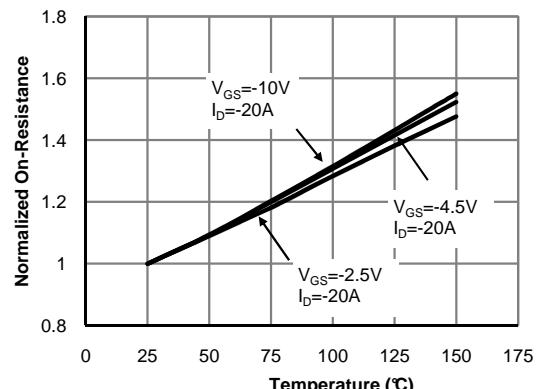


Figure 4: On-Resistance vs. Junction Temperature (Note E)

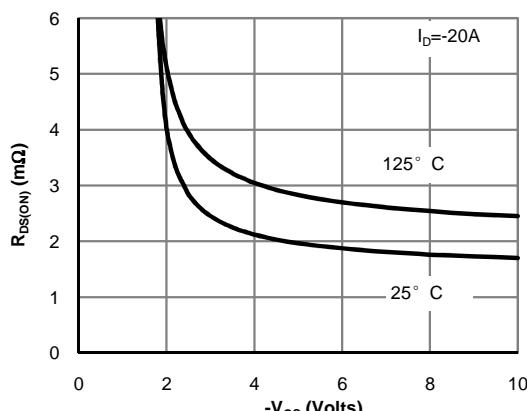


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

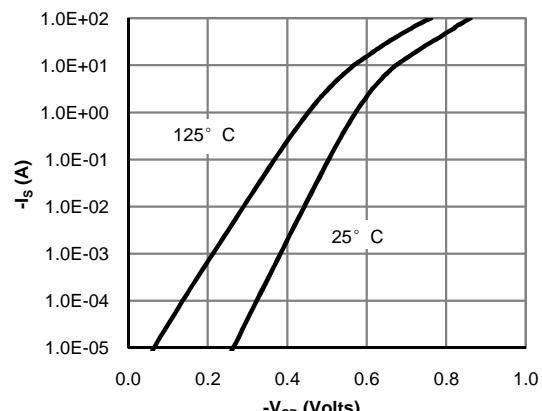


Figure 6: Body-Diode Characteristics (Note E)

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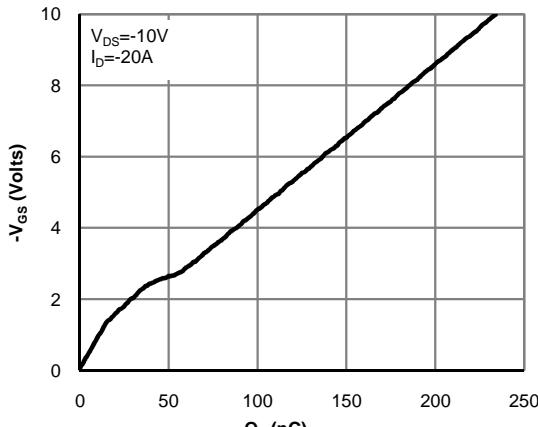


Figure 7: Gate-Charge Characteristics

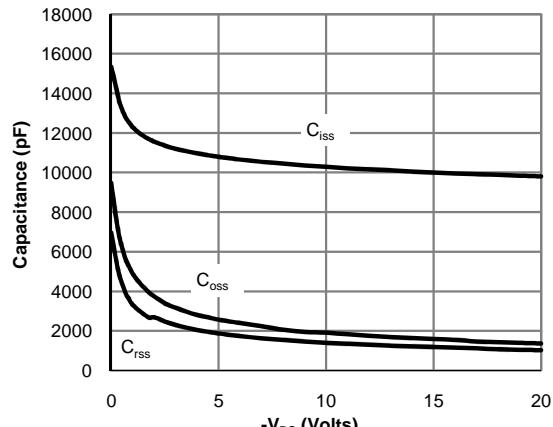


Figure 8: Capacitance Characteristics

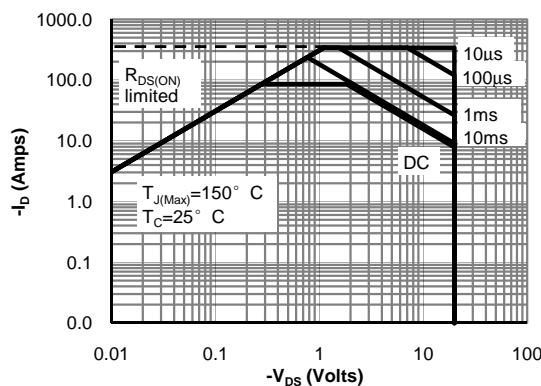


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

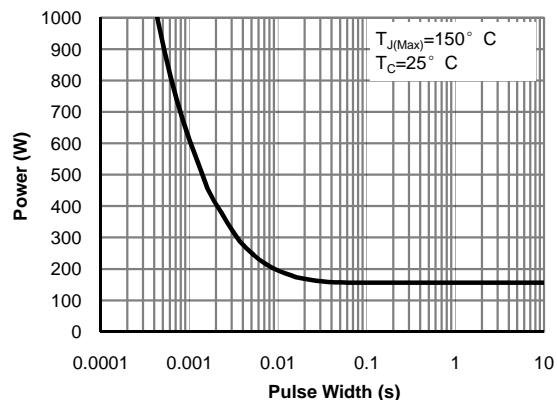


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

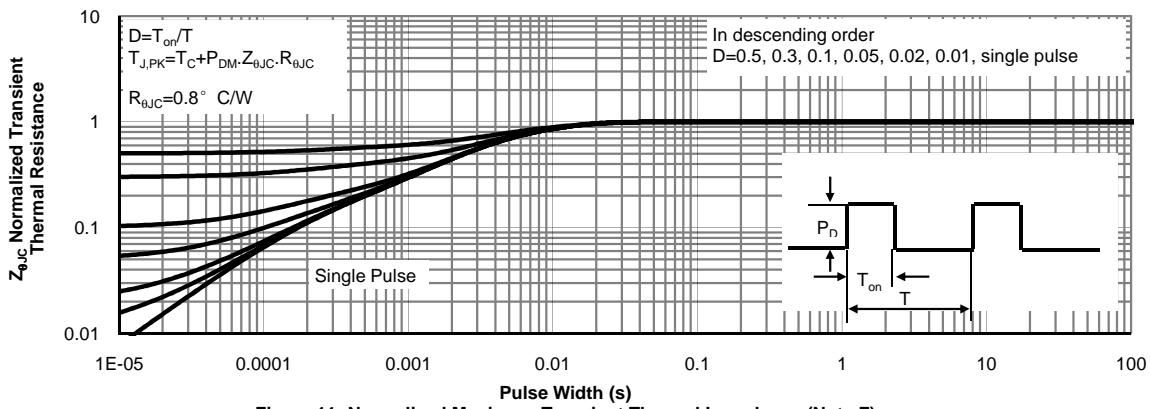
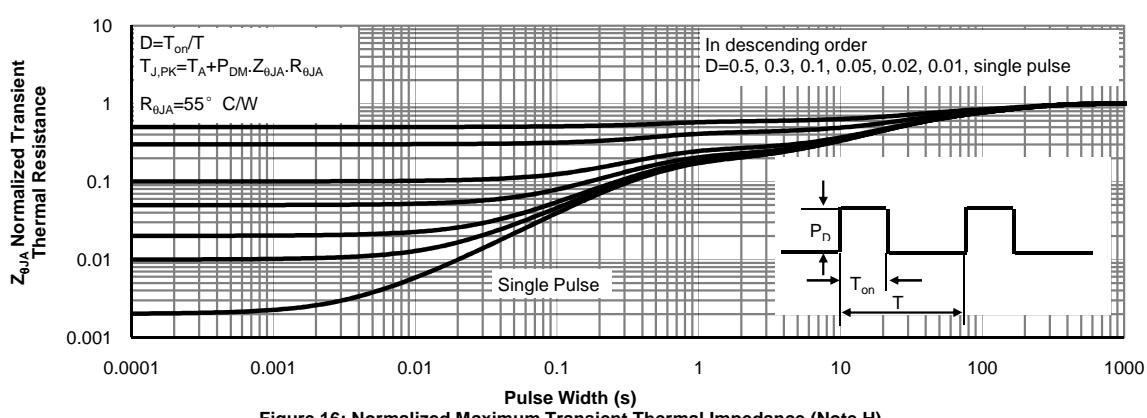
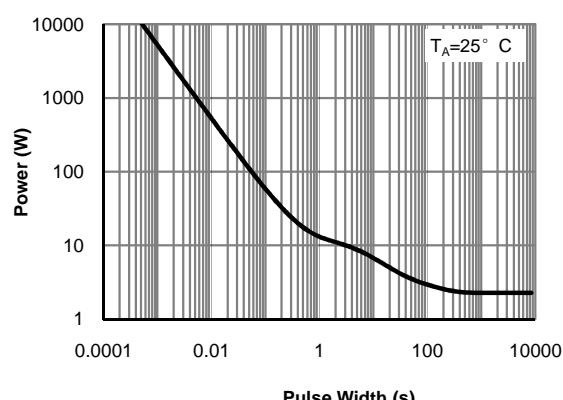
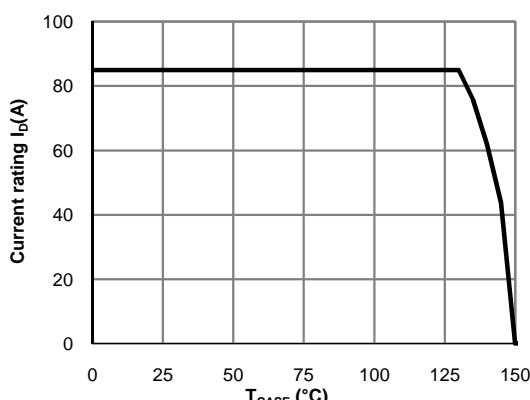
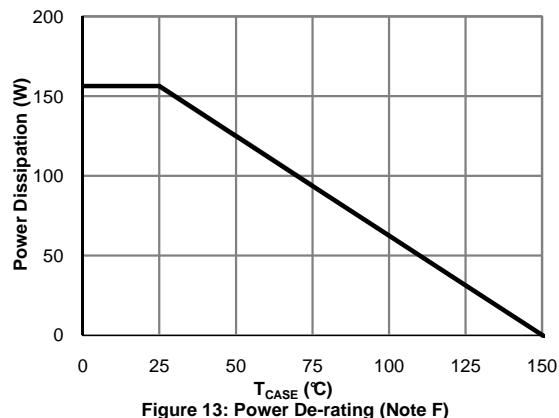
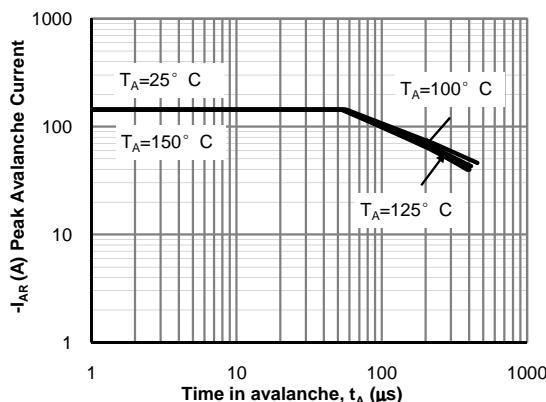
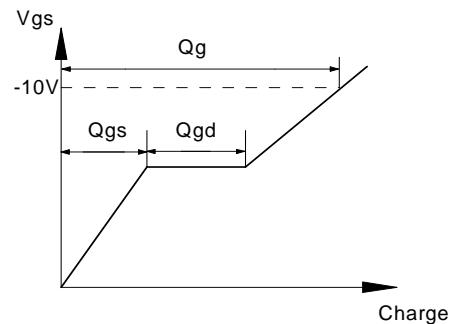
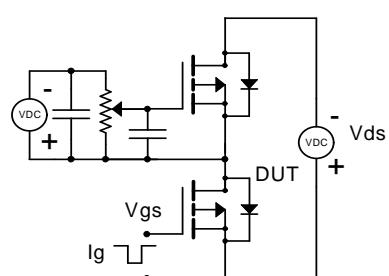


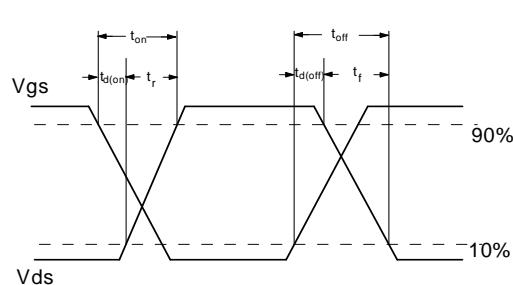
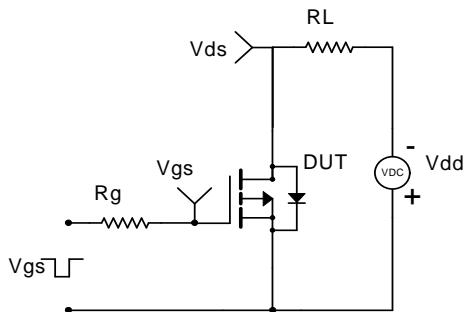
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


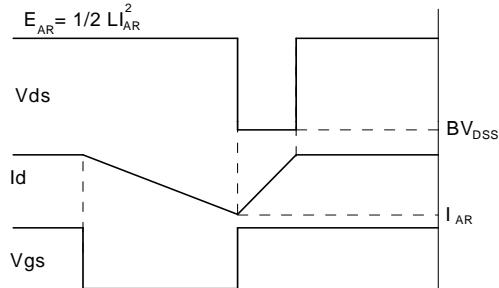
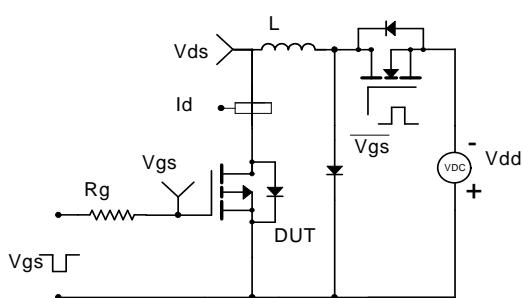
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

